

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,419	TIWARI ET AL.	
Examiner	Art Unit	
Andre Diegre Levie	2422	

	SEAR	CHED	
Class	Subclass	Date	Examiner
703	2,11	10/27/2006	APL
716	004	10/27/2006	APL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (EAST (US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT;IBM_TDB)- SEE ATTACHMENT	10/27/2006	APL		
Inventor Name Search	10/27/2006	APL		
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